


<b>Search Notes</b>  	<b>Application/Control No.</b>  10535526	<b>Applicant(s)/Patent Under Reexamination</b>  NAKAMURA ET AL.
	<b>Examiner</b>  LI LIU	<b>Art Unit</b>  2613

SEARCHED			
Class	Subclass	Date	Examiner
398	1-7, 9-24, 28, 30-34, 66-72, 79, 93, 95, 137, 139-141, 162, 202	3/16/2008	LL
385	37, 42, 50	3/16/2008	LL

SEARCH NOTES			
Search Notes		Date	Examiner
EAST: US-PGPUB, USPAT, EPO, JPO, IBM_TDB		3/13-3/16, 2008, 10/16/2008	LL
IEEE, GOOGLE		3/14/2008, 10/16/2008	LL
PLUS		3/13/2008	LL

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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